Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/623,425	CHEN ET AL.	
Examiner	Art Unit	
Sajous Wesner	2676	

	SEAR	CHED	
Class	Subclass	Date	Examiner
345	418-421, 426, 428, 581-587	10/14/2005	ws
	441-443		
	473	\downarrow	\bigvee

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
345	441-442	10/14/2005	ws	
\bigvee	418, 582	V	V	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Classified search including US- PGPUB, EPO, JPO, IBM, TDB, & Derwent searches conducted in West	10/14/2005	ws